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Optoelectronics Materials and Devices for Sensing and Imaging

Yadong Jiang Junsheng Yu Bernard Kippelen Editors

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Contents

- ix Symposium Committee
- xi Introduction
- xiii AOMATT 2014 Sponsors

ORAL SESSION

9284 02 Development of the large area MCP-PMT [9284-54]

S. Liu, Y. Wang, T. Zhao, Institute of High Energy Physics (China); H. Liu, Xi'an Institute of Optics and Precision Mechanics (China); S. Si, North Night Vision Technology Group Co., Ltd. (China); J. Tian, Xi'an Institute of Optics and Precision Mechanics (China); S. Qian, Institute of High Energy Physics (China); J.-N. Sun, North Night Vision Technology Group Co., Ltd. (China); X. Cai, Institute of High Energy Physics (China); D. Li, L. Chen, Xi'an Institute of Optics and Precision Mechanics (China); B. Yan, Y. Yang, Institute of High Energy Physics (China)

9284 03 Research on polarizing performance of Au-SiO₂ sub-wavelength hybrid grating in short wave infrared (SWIR) [9284-48]

W. Rui, Shanghai Institute of Technical Physics (China) and Univ. of Chinese Academy of Sciences (China); T. Li, X. Shao, X. Li, H. Gong, Shanghai Institute of Technical Physics (China)

9284 04 Highly efficient non-doped orange-red phosphorescent organic light-emitting devices based on a novel iridium complex [9284-53]

Y. Qi, X. Wang, Univ. of Electronic Science and Technology of China (China); M. Li, Sichuan Univ. (China); J. Yu, Univ. of Electronic Science and Technology of China (China); Z. Lu, Sichuan Univ. (China)

9284 05 High photo-response organic ultraviolet photodectectors based on phosphorescent materials [9284-25]

X. Wang, J. Yu, J. Huang, Univ. of Electronic Science and Technology of China (China)

9284 06 Performance of extended wavelength InGaAs/InAsP SWIR detector [9284-47]

G. Cao, Shanghai Institute of Technical Physics (China) and Univ. of Chinese Academy of Sciences (China); T. Li, H. Tang, X. Shao, X. Li, H. Gong, Shanghai Institute of Technical Physics (China)

9284 07 Characteristic analysis on the thermal noise of infrared CCD [9284-58]

R.-Z. Zhang, X. Yu, Sichuan Univ. (China); G.-D. Liu, Institute of Fluid Physics (China)

9284 08 The transmission characteristics of laser in multilayer coatings [9284-18]

L. Du, R. Zhang, Sichuan Univ. (China)

9284 09 Smell sensing and visualizing based on multi-quantum wells spatial light modulator [9284-10]

F. Tian, Z. Zhao, P. Jia, H. Liao, D. Chen, Chongqing Univ. (China); S. Liu, Chongqing Academy of Metrology and Quality Inspection (China)

POSTER SESSION

- 9284 0A Influence of bandgap grading of intrinsic layer and annealing post on the optical and electrical performance of amorphous silicon germanium thin film solar cells [9284-1]

 B. Yan, S. Liu, Institute of High Energy Physics (China); L. Zhao, W. Wang, Institute of Electrical Engineering (China); Y. Yang, Guangxi Univ. (China)
- 9284 0B **BBO crystal component design for ultra-short laser pulse measurement** [9284-65] Y. Jia, X. Zhang, Beijing Information Science and Technology Univ. (China); T. Zhang, Air Defense Forces Academy (China); L. Lu, Beijing Information Science and Technology Univ. (China)
- 9284 0C The effect of spin coating parameters on the performance of PTB7/PC71BM polymer solar cells [9284-46]
 - J. Li, S. Li, Y. Zheng, J. Yu, Univ. of Electronic Science and Technology of China (China)
- 9284 0D Star point centroid algorithm based on background forecast [9284-28]
 J. Wang, Institute of Optics and Electronics (China) and Univ. of Electronic Science and Technology of China (China); R. Zhao, Institute of Optics and Electronics (China); N. Zhu, Beijing Institute of Control Engineering (China)
- 9284 0E Study of an image restoration method based on Poisson-maximum likelihood estimation method for earthquake ruin scene [9284-13]
 Y. Song, J. Yang, L. Cheng, S. Liu, Institute of Disaster Prevention (China)
- 9284 0F **Detailed analysis of bulk heterojunction organic solar cells based on P3HT:PCBM** [9284-12] J. Zhong, M. Deng, F. Gan, H. Chen, L. Wang, Univ. of Electronic Science and Technology of China (China)
- 9284 0G A method of color correction of camera based on HSV model [9284-62]
 R. Zhao, J. Wang, G. Yu, J. Zhong, W. Zhou, Institute of Optics And Electronics (China); Y. Li, Shanghai Aerospace Control Technology Research Institute (China)
- 9284 0H Study on photoemission surface of varied doping GaN photocathode [9284-61]
 J. Qiao, R. Du, Nanyang Institute of Technology (China); H. Ding, Nanjing Univ. of Science and Technology (China); Y. Gao, Nanyang Institute of Technology (China); B. Chang, Nanjing Univ. of Science and Technology (China)
- 9284 01 Star identification independence on the camera parameters [9284-60]
 D. Su, Naval Aeronautical and Astronautical Univ. (China); D. Chen, New Star Research Institute of Applied Technology (China); M. Zhou, K. Wang, Naval Aeronautical and Astronautical Univ. (China)
- 9284 0J Comparison of dye doping and ultrathin emissive layer in white organic light-emitting devices with dual emissive layers [9284-16]
 X. Wang, Y. Qi, J. Yu, Univ. of Electronic Science and Technology of China (China)

- 9284 0K

 Measurement error analysis of three dimensional coordinates of tomatoes acquired using the binocular stereo vision [9284-34]

 R. Xiang, China Jiliang Univ. (China)
- 9284 OL Some improvements on the auto-gated power for low-light level image intensifier [9284-35] Y. Yang, B. Yan, Q. Zhi, Z. Yao, J. Li, L. Fu, Y. Yuan, G. Deng, Science and Technology on Low-Light-Level Night Vision Lab. (China) and North Night Vision Technology Group Co., Ltd. (China)
- 9284 0M The study of the effect on the organic emitting diodes with (t-bt)2lr(acac) as deep hole-trap [9284-72]
 M. Deng, J. Zhong, K. Gu, J. Chen, Y. Chen, Univ. of Electronic Science and Technology of China (China)
- 9284 0N A multi-focus image adaptive fusion method based on comprehensive index [9284-27] H. Lu, Xi'an Institute of Optics and Precision Mechanics (China) and Univ. of Chinese Academy of Sciences (China); Z. Song, W. Gao, Xi'an Institute of Optics and Precision Mechanics (China); Q. Wang, J. Xi, Xi'an Institute of Optics and Precision Mechanics (China) and Univ. of Chinese Academy of Sciences (China)
- 9284 00 Compressed sensing based on the improved wavelet transform for image processing [9284-32]
 P. Pang, Xi'an Institute of Optics and Precision Mechanics (China) and Univ. of Chinese Academy of Sciences (China); W. Gao, Z. Song, Xi'an Institute of Optics and Precision Mechanics (China); J. XI, Xi'an Institute of Optics and Precision Mechanics (China) and Univ. of Chinese Academy of Sciences (China)
- 9284 0P **Properties of InGaN P-I-N ultraviolet detector** [9284-70]
 Y. Lu, Shanghai Institute of Technical Physics (China) and Univ. of Chinese Academy of Sciences (China); Y. Zhang, X. Li, Shanghai Institute of Technical Physics (China)
- 9284 0Q Maneuvering target tracking based on multiple model methods [9284-71]
 S. Li, Univ. of Chinese Academy of Sciences (China) and Institute of Optics and Electronics (China) and Key Lab. of Beam Control (China); Q. Bao, Institute of Optics and Electronics (China) and Key Lab. of Beam Control (China)
- 9284 OR An analysis of the optimal size of image sensors in free space optic systems [9284-8]
 L. Li, Institute of Optics and Electronics (China) and Univ. of Chinese Academy of Sciences (China); Y. Huang, T. An, Institute of Optics and Electronics (China)
- 9284 0S Infrared absorption mechanisms of black silicon [9284-36]
 Z. Cheng, Y. Chen, B. Ma, Shanghai Institute of Technical Physics (China)
- 9284 0T Change of the surface potential barrier of GaAs photocathode during two-step activation [9284-66]
 J. Niu, Nanjing Univ. of Science and Technology (China) and Nanyang Institute of Technology (China); Y. Gao, Y. Qian, B. Chang, Nanjing Univ. of Science and Technology (China)

9284 OU	Effects of thermal annealing on photoluminescence spectra in π -conjugated polymer film: evidence for dual emission by temperature dependent measurements [9284-4] R. Z. Wang, X. Yang, Y. C. Wang, CX. Sheng, Q. Chen, Nanjing Univ. of Science and Technology (China)
9284 OV	Continuous-wave photoinduced absorption studies in long lived photoexcitation of π -conjugated polymer and fullerene blended films [9284-6] X. Yang, H. Li, Y. C. Wang, R. Z. Wang, CX. Sheng, Nanjing Univ. of Science and Technology (China)
9284 OW	Measurements of amplified spontaneous emission in π -conjugated polymer films with different morphology [9284-7] Y. Wang, X. Yang, R. Wang, C. Sheng, Nanjing Univ. of Science and Technology (China)
9284 OX	A hole-filling algorithm based on pixel labeling for DIBR [9284-45] L. Lei, Z. Chen, J. Shi, Yunnan Normal Univ. (China)
9284 OY	Influence of ageing processing on GaAs photocathode of 3 rd generation low-light-level image intensifier [9284-38] L. Feng, F. Shi, L. Yin, Z. Miao, H. Cheng, L. Wang, S. Niu, X. Zhang, Science and Technology on Low-Light-Level Night Vision Lab. (China) and North Night Vision Technology Group Co., Ltd. (China)
9284 OZ	Arsenic volatilization of GaAs photocathode at low temperature during thermal cleaning [9284-42] H. Liu, F. Shi, Z. Miao, X. Gao, H. Cheng, S. Niu, L. Wang, C. Chen, Science and Technology on Low-Light-Level Night Vision Lab. (China) and North Night Vision Technology Group Co., Ltd. (China)
9284 10	Characteristic of photocurrent decline of transmission-mode equally doped GaAs photocathode [9284-43] D. Zhang, F. Shi, X. Gao, H. Cheng, Z. Miao, S. Niu, L. Wang, C. Chen, Science and Technology on Low-Light-Level Night Vision Lab. (China) and North Night Vision Technology Group Co., Ltd. (China)
9284 11	Analysis of electric vacuum characteristics of MCP [9284-39] X. Gao, F. Shi, H. Cheng, L. Yin, Z. Miao, X. Cheng, L. Wang, S. Niu, Science and Technology on Low-Light-Level Night Vision Lab. (China) and North Night Vision Technology Group Co., Ltd. (China)
9284 12	An improved method of edge detection based on the mean shift algorithm [9284-33] L. Wei, B. Liu, J. Mou, Xi'an Institute of Optics and Precision Mechanics (China)
9284 13	The simulation and analysis of infrared target multi-band characteristics [9284-31] L. Cui, Institute of Optics and Electronics (China) and Univ. of the Chinese Academy of

Sciences (China); J. Zhou, Institute of Optics and Electronics (China)

9284 14	pulsed dc reactively sputtered vanadium oxide thin films [9284-11] X. Dong, Z. Wu, Y. Jiang, X. Xu, H. Yu, D. Gu, T. Wang, Univ. of Electronic Science and Technology of China (China)
9284 15	Optoelectronic correlator based on YUV color model with shifted training images for color image recognition [9284-40] Y. Li, C. Chen, H. Chen, Y. Hsieh, Yuan Ze Univ. (Taiwan)
9284 16	Design of area array CCD image acquisition and display system based on FPGA [9284-41] L. Li, N. Zhang, T. Li, Y. Pan, Y. Dai, Changchun Univ. of Science and Technology (China)
9284 17	Research of ion feedback-induced noise of micro-channel plate [9284-44] D. Li, Y. Zhu, N. Zhang, J. Nie, F. Zhang, T. Zhang, S. Li, X. Liu, Z. Liu, Science and Technology on Low-Light-Level Night Vision Lab. (China) and North Night Vision Technology Group Co., Ltd. (China)
9284 18	Ghost detection and removal based on super-pixel grouping in exposure fusion [9284-63] S. Jiang, Z. Xu, Q. Li, Y. Chen, H. Feng, Zhejiang Univ. (China)
9284 19	Blind deconvolution using an improved L0 sparse representation [9284-68] P. Ye, H. Feng, Q. Li, Z. Xu, Y. Chen, Zhejiang Univ. (China)
9284 1A	A study of the non-uniform current density influence in reactive sputtering deposition [9284-30] T. Wang, H. Yu, C. Chen, Y. Wang, Y. Jiang, Univ. of Electronic Science and Technology of China (China)
9284 1C	Preparation and mechanical properties of the MgAl ₂ O ₄ transparent phosphor ceramics [9284-17] X. Bai, Z. Li, M. Lei, Z. Pang, Bright Crystals Technology Inc. (China)
9284 1D	A low-temperature bridge-input CMOS circuit for low-impedance detector [9284-23] H. Yuan, Y. Chen, Shanghai Institute of Technical Physics (China)
9284 1E	Simulation of terahertz metamaterial absorbers with microbolometer structure [9284-20] J. Ding, J. Wang, X. Guo, Y. Jiang, L. Fan, Univ. of Electronic Science and Technology of China (China)
9284 1F	Study on preparation and polarization process of PVDF thin film [9284-15] X. Guo, J. Wang, J. Ding, Y. Jiang, Univ. of Electronic Science and Technology of China (China)

- Cooperative chemisorption of K and O elements on cleaved GaAs(110) surface [9284-51]
 B. Ren, Science and Technology on Low-Light-Level Night Vision Lab. (China) and North Night Vision Technology Group Co., Ltd. (China) and Beijing Institute of Technology (China); Z. Miao, Z. Hou, H. Cheng, F. Shi, G. Jiao, X. Bai, S. Niu, L. Wang, L. Fu, Science and Technology on Low-Light-Level Night Vision Lab. (China) and North Night Vision Technology Group Co., Ltd. (China)
- 9284 1H Research on theory of the silicon material electro-optic modulator [9284-49] Y. Zhang, W. Li, H. Liu, Jilin Jianzhu Univ. (China)
- 9284 11 An effective segmentation cue for moving object segmentation from a moving camera [9284-19]

S. Wang, Luoyang Institute of Electro-Optical Equipment (China); M. Wu, Luoyang Optoelectronic Technology Development Ctr. (China); Y. Xie, Luoyang Institute of Electro-Optical Equipment (China) and Science and Technology on Electro-optic Control Lab. (China)

Author Index

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Introduction

The 7th International Symposium on Advanced Optical Manufacturing and Testing Technology (AOMATT) was held 26–29 April 2014 at the Harbin International Conference Center, China.

AOMATT 2014 was kicked off with a formal opening ceremony. The ceremony started with the introduction of VIP guests, symposium chairs, conference chairs, and plenary speakers, followed by opening speeches by Prof. Liwei Zhou, AOMATT 2014 Symposium Chairman, Prof. Bin Xu, Vice President of IOE, a sponsor of AOMATT 2014, and Prof. Yingchun Liang, Assistant President of Harbin Institute of Technology, a local co-sponsor of AOMATT 2014. Dr. H. Philip Stahl, 2014 President of SPIE, technical cosponsor of AOMATT 2014, could not attend the symposium this year due to a schedule conflict, but sent his congratulation letter. In his letter, Dr. Stahl gave high marks for AOMATT and stated:

AOMATT is a very successful collaboration between SPIE, the Institute of Optics and Electronics of the Chinese Academy of Sciences, and the Chinese Optical Society. It has become a well-known international symposium on advanced optical manufacturing and testing technologies. The vision of AOMATT is closely aligned with SPIE's mission to promote optics and photonics around the world.

All of the conference sponsors and attendees greatly appreciate SPIE and Dr. Stahl's long-standing support of AOMATT since its inception in 2002.

The plenary sessions started immediately after the conclusion of the opening ceremony. There were a total of nine plenary presentations: Dr. Larry Stepp, Telescope Department Head for the Thirty Meter Telescope (TMT) Project, USA, presented "Manufacturing the Optics for the Thirty Meter Telescope"; Dr. Bernard Delabre, Optical Design Engineer of European Southern Observatory (ESO), Germany, presented "The Progress of the European Extremely Large Telescope"; Dr. Tao Sun, Director of the Centre for Precision Engineering(CPE) of Harbin Institute of Technology, presented "Method and procedure for the highefficiency and ultra-precision diamond turning of large optical mirrors"; Dr. Wei Gao, Professor and Director of Research Center for Precision Nanosystems, Dept. of Nanomechanics of Tohoku University, Japan, presented "Precision nanometrology for fabrication of micro optics"; Dr. Xuejun Zhang, Vice President of Changchun Institute of Optics, Fine Mechanics and Physics (CIOMP), CAS, presented "Advanced manufacturing and testing technologies for multiple mirror space telescopes"; Dr. A.G. Poleshchuk, Head of the Laboratory of Diffractive Optics, and Dr. Victor P. Korolkov, senior scientist of Institute of Automation and Electrometry, Siberian Branch of Russian Academy of Sciences, Novosibirsk, Russia, presented "Diffractive optical elements: fabrication and application"; Dr.

Axel Schindler, Science and Technology Consultant of Leibniz Institute of Surface Modification (IOM), Germany, presented "Advanced ion beam finishing and atmospheric plasma technology for high end optics"; Dr. Harald Giessen, Chair for Ultrafast Nano-Optics in the Department of Physics at the University of Stuttgart, Germany, presented "Complex hybrid plasmonics: new materials and new functionalities"; Dr. Xiangang Luo, Director of State Key Laboratory of Optical Technologies on Nano-Fabrication and Micro-Engineering of Institute of Optics and Electronics, CAS, presented "Manipulating the polarization states of electromagnetic waves using subwavelength structures". More than 600 people attended the opening ceremony and the full-day plenary sessions.

More than 400 oral and poster papers were selected for AOMATT 2014. About 102 oral papers were presented in six parallel conference sessions on 27 April. A special Technical Workshop was held in the morning of 28 April. An all-symposium poster session was held in the afternoon of 28 April. Authors and attendees had active discussions and exchange of ideas throughout the symposium. Many papers presented cutting-edge research and development work in optical design, manufacturing, and testing. The success of AOMATT 2014 continued the tradition of focus and excellence of this biannual international topical symposium in China.

We would like to express our sincere appreciation to COS—The Chinese Optical Society, IOE—Institute of Optics and Electronics, Chinese Academy of Sciences, and to SPIE for sponsoring and supporting AOMATT 2014. We would like to thank all chairs, committee members, authors, and attendee for their contributions to the symposium and sharing their research with colleagues around the world.

The 8th AOMATT is planned for 2016, and we look forward to seeing everyone at AOMATT 2016. Please watch for the Call for Papers and symposium announcements on the SPIE, IOE and COS web sites.

Li Yang Secretary General, AOMATT 2014

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